



HS3A THRU HS3M

高效整流二极管 High Efficient Rectifier

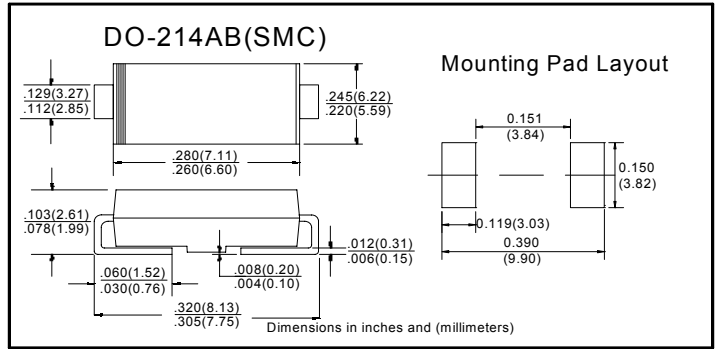
■特征 Features

- I_o 3.0A
- V_{RRM} 50V-1000V
- 耐正向浪涌电流能力高
High surge current capability
- 封装: 模压塑料
Cases: Molded plastic

■用途 Applications

- 整流用 Rectifier

■外形尺寸和印记 Outline Dimensions and Mark



■极限值 (绝对最大额定值)

Limiting Values (Absolute Maximum Rating)

参数名称 Item	符号 Symbol	单位 Unit	测试条件 Test Conditions	HS3						
				A	B	D	G	J	K	M
反向重复峰值电压 Repetitive Peak Reverse Voltage	V_{RRM}	V		50	100	200	400	600	800	1000
正向平均电流 Average Forward Current	$I_{F(AV)}$	A	正弦半波 60Hz, 电阻负载, TL=110°C 60Hz Half-sine wave, Resistance load, TL =110°C	3						
正向 (不重复) 浪涌电流 Surge(Non-repetitive)Forward Current	I_{FSM}	A	正弦半波 60Hz, 一个周期, Ta=25°C 60Hz Half-sine wave, 1 cycle, Ta =25°C	150						
结温 Junction Temperature	T_J	°C		-55~+150						
储存温度 Storage Temperature	T_{STG}	°C		-55 ~ +150						

■电特性 (Ta=25°C 除非另有规定)

Electrical Characteristics (Ta=25°C Unless otherwise specified)

参数名称 Item	符号 Symbol	单位 Unit	测试条件 Test Condition	HS3						
				A	B	D	G	J	K	M
正向峰值电压 Peak Forward Voltage	V_F	V	$I_F=3.0A$	1.0			1.3		1.7	
最大反向恢复时间 Maximum reverse recovery time	t_{rr}	ns	$I_F=0.5A, I_R=1.0A, I_{rr}=0.25A$	50			75			
反向漏电流 Peak Reverse Current	I_{RRM1}	μA	$V_{RM}=V_{RRM}$	$T_a=25^\circ C$		10				
	I_{RRM2}			$T_a=100^\circ C$		200				
热阻(典型) Thermal Resistance(Typical)	$R_{\theta J-A}$	°C/W	结和环境之间 Between junction and ambient		47 ¹⁾					
	$R_{\theta J-L}$		结和终端之间 Between junction and terminal		13 ¹⁾					

备注: Notes:

¹⁾ 热阻从结到环境及从结到引线, 在电路板的0.3" x 0.3" (8.0毫米 x 8.0毫米)铜垫片区

Thermal resistance from junction to ambient and from junction to lead mounted on P.C.B. with 0.3" x 0.3" (8.0 mm x 8.0 mm) copper pad areas

■ 特性曲线 (典型) Characteristics(Typical)

图1: 正向电流降额曲线
FIG.1: FORWARD CURRENT DERATING CURVE

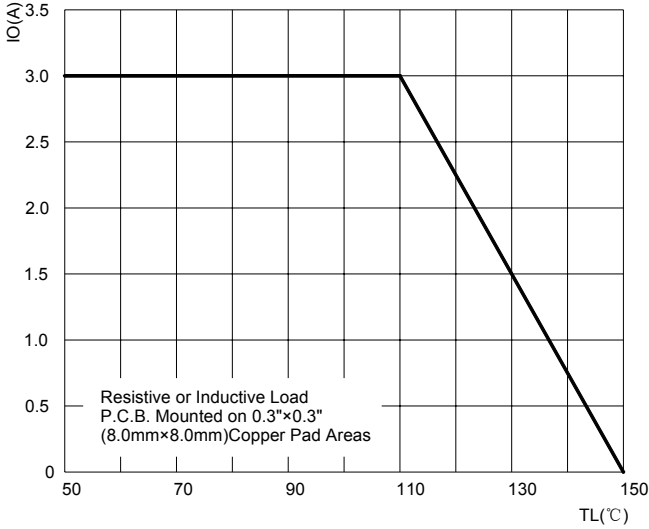


图2: 最大正向浪涌冲击耐受力
FIG.2: MAXIMUM NON-REPETITIVE FORWARD URGE CURRENT

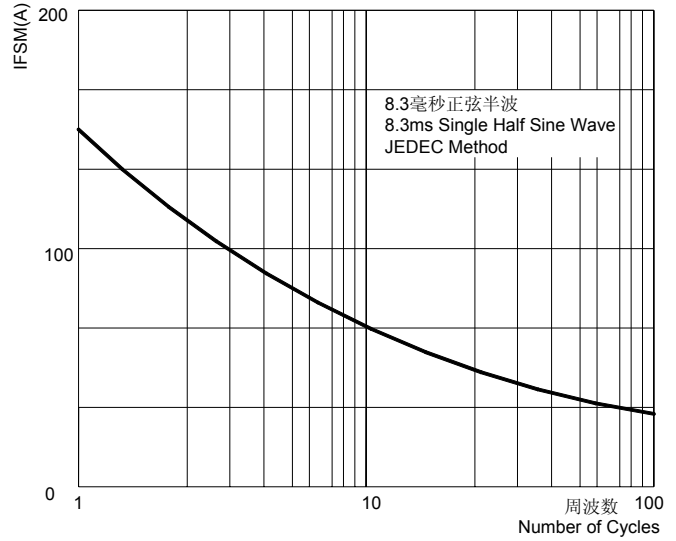


图3: 典型正向特性曲线
FIG.3: TYPICAL FORWARD CHARACTERISTICS

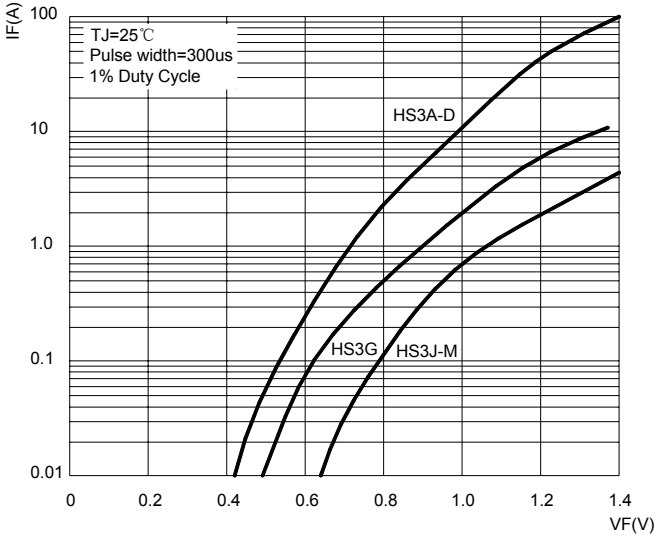


图4: 典型反向特性曲线
FIG.4: TYPICAL REVERSE CHARACTERISTICS

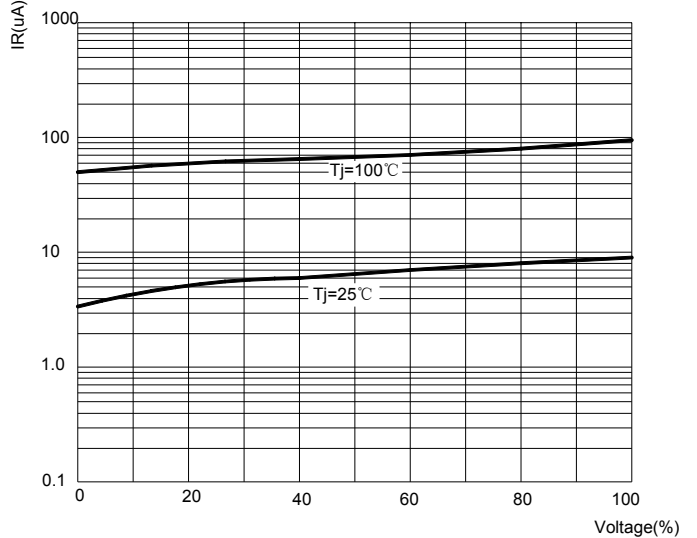


图5: 反向恢复时间试验电路及测试波形示意图
FIG.5: Diagram of circuit and Testing wave form of reverse recovery time

